## Applicant(s)/Patent Under Application/Control No. Reexamination 10/725,514 HEENEY ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Shean C. Wu 1756 **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code Name MM-YYYY 08-2000 438/99 US-6,107,117 Bao et al. Α US-В US-С US-D Е US-F US-US-G US-Н US-1 US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν O Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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